

<b>Notice of References Cited</b>	Application/Control No. 10/827,215	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0232184 A1	10-2005	Borella, Michael	370/328
*	B	US-2005/0135240 A1	06-2005	Ozugur, Timucin	370/229
*	C	US-7,224,987 B1	05-2007	Bhela et al.	455/456.3
*	D	US-2004/0198389 A1	10-2004	Alcock et al.	455/456.1
*	E	US-2005/0208954 A1	09-2005	Boss et al.	455/456.1
*	F	US-2002/0165910 A1	11-2002	Brown et al.	709/203
*	G	US-2005/0079873 A1	04-2005	Caspi et al.	455/456.1
*	H	US-7,224,966 B2	05-2007	Caspi et al.	455/419
*	I	US-7,130,630 B1	10-2006	Enzmann et al.	455/435.1
*	J	US-7,046,657 B2	05-2006	Harrington et al.	370/350
*	K	US-7,269,426 B2	09-2007	Kokkonen et al.	455/456.1
*	L	US-2006/0135174 A1	06-2006	Kraufvelin et al.	455/456.1
*	M	US-2007/0037582 A1	02-2007	Mohi et al.	455/456.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0148342 A1	07-2005	Sylvain, Dany	455/456.3
*	B	US-2004/0153506 A1	08-2004	Ito et al.	709/204
*	C	US-2002/0055924 A1	05-2002	Liming, Richard	707/100
*	D	US-2004/0177134 A1	09-2004	Lonnfors et al.	709/220
*	E	US-2004/0166879 A1	08-2004	Meadows et al.	455/456.1
*	F	US-7,263,086 B2	08-2007	Viikari et al.	370/338
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

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	N					
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